

UNISONIC TECHNOLOGIES CO., LTD

01N45 Preliminary Power MOSFET

0.1A, 450V N-CHANNEL POWER MOSFET

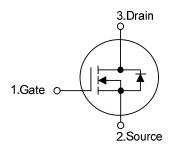
■ DESCRIPTION

The UTC **01N45** is a N-channel mode power MOSFET using UTC's advanced technology to provide customers with a minimum on-state resistance, low gate charge and superior switching performance.

■ FEATURES

- * $R_{DS(ON)} \le 16\Omega$ @ $V_{GS}=10V$, $I_{D}=0.05A$
- * High switching speed
- * Typically 5.76nC low gate charge
- * 100% avalanche tested





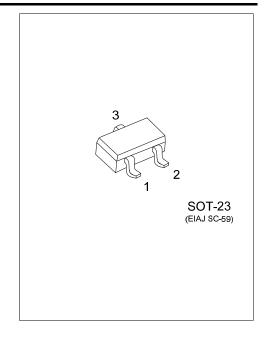
ORDERING INFORMATION

| Ordering | Dackage | Pin Assignment | | | Dooking | |
|--|--------------|----------------|---|---|---------|-----------|
| Lead Free | Halogen Free | Package | 1 | 2 | 3 | Packing |
| 01N45L-AE3-R | 01N45G-AE3-R | SOT-23 | G | S | D | Tape Reel |
| Note: Pin Assignment: G: Gate S: Source D: Drain | | | | | | |

01N45G-AE3-R
(1)Packing Type
(1) R: Tape Reel
(2) AE3: SOT-23
(3) G: Halogen Free and Lead Free, L: Lead Free

MARKING





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■ ABSOLUTE MAXIMUM RATINGS

| PARAMETER | SYMBOL | RATINGS | UNIT | |
|--------------------------|------------------|--------------------|----------|--|
| Drain-Source Voltage | V_{DSS} | 450 | V | |
| Gate-Source Voltage | V_{GSS} | ±30 | V | |
| Continuous Drain Current | I_D | 0.1 | Α | |
| Avalanche Current | I _{AR} | 0.1 | Α | |
| Power Dissipation | P _D | 0.3 | W | |
| Junction Temperature | TJ | +150 | °C | |
| Storage Temperature | T _{STG} | -55 ~ + 150 | °C | |

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature

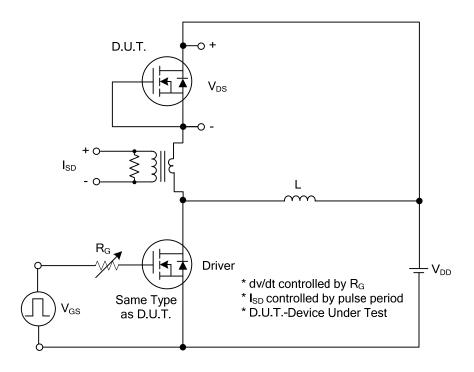
■ ELECTRICAL CHARACTERISTICS

| PARAMETER | | SYMBOL | TEST CONDITIONS | | TYP | MAX | UNIT |
|---|-----------|---------------------|--|-----|------|------|------|
| OFF CHARACTERISTICS | | | | | | | |
| Drain-Source Breakdown Voltage | | BV_{DSS} | I _D =250μA, V _{DS} =0V | 450 | | | V |
| Drain-Source Leakage Current | | I_{DSS} | V _{DS} =450V | | | 10 | μΑ |
| Gate-Source Leakage Current | Forward | Lasa | V _{GS} =+30V, V _{DS} =0V | | | +100 | nA |
| | Reverse | I_{GSS} | V_{GS} =-30V, V_{DS} =0V | | | -100 | nA |
| ON CHARACTERISTICS | | | | | | | |
| Gate Threshold Voltage | | $V_{GS(TH)}$ | I _D =250μA | 1.0 | | 3.0 | V |
| Static Drain-Source On-State Resistance | | R _{DS(ON)} | V _{GS} =10V, I _D =0.05A | | | 16 | Ω |
| DYNAMIC PARAMETERS | | | | | | | |
| Input Capacitance | | C _{ISS} | | | 133 | | pF |
| Output Capacitance | | Coss | V_{GS} =0V, V_{DS} =25V, f=1MHz | | 13 | | pF |
| Reverse Transfer Capacitance | | C_{RSS} | | | 5 | | pF |
| SWITCHING PARAMETERS | | | | | | | |
| Total Gate Charge | | Q_G | V _{DS} =50V, V _{GS} =10V, I _D =0.5A | | 5.76 | | nC |
| Gate to Source Charge | | Q_GS | I _G = 100μA (Note1, 2) | | 0.26 | | nC |
| Gate to Drain Charge | | Q_GD | ig= τουμΑ (Note 1, 2) | | 0.54 | | nC |
| Turn-ON Delay Time | | $t_{D(ON)}$ | | | 14.4 | | ns |
| Rise Time | | t _R | V_{DS} =30V, V_{GS} =10V, I_{D} =0.5A, | | 16.8 | | ns |
| Turn-OFF Delay Time | | t _{D(OFF)} | R _G =25Ω (Note1, 2) | | 62.8 | | ns |
| Fall-Time | | t_{F} | | | 46 | | ns |
| SOURCE- DRAIN DIODE RATII | NGS AND (| CHARACTERI | STICS | | | | |
| Drain-Source Diode Forward Voltage | | V_{SD} | I _S =0.1A,V _{GS} =0V | | | 1.4 | V |
| Maximum Body-Diode Continuous Current | | I _S | | | | 0.1 | Α |
| Maximum Body-Diode Pulsed Current | | I _{SM} | | | | 0.4 | Α |
| Reverse Recovery Time | | t _{rr} | V _{GS} =0V, I _S =0.1A, | | 43.6 | | ns |
| Reverse Recovery Charge | | Q_{rr} | dI _F /dt=100A/μs | | 49 | | nC |

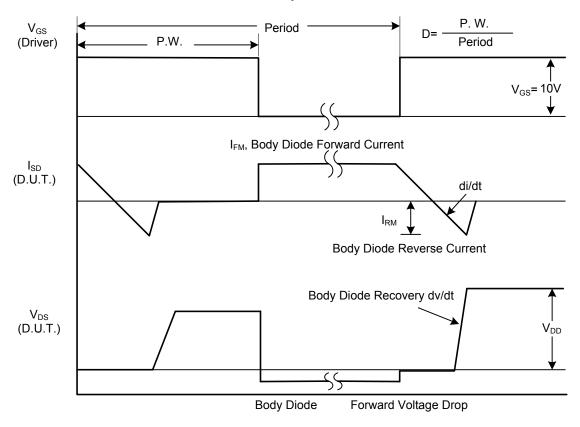
Notes: 1. Pulse Test : Pulse width ≤300µs, Duty cycle ≤2%.

2. Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS

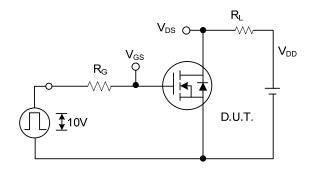


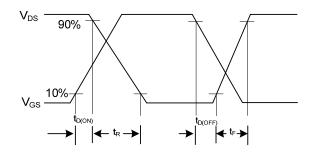
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

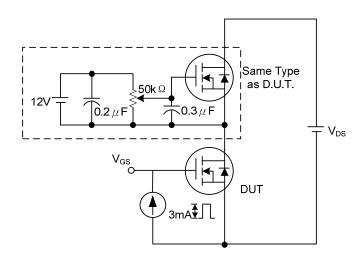
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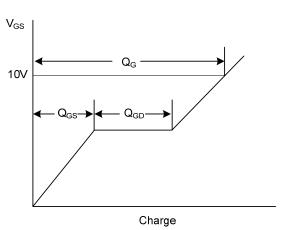




Switching Test Circuit

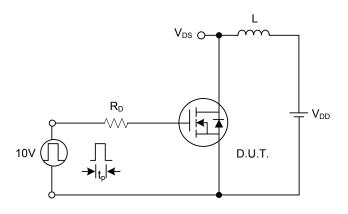
Switching Waveforms

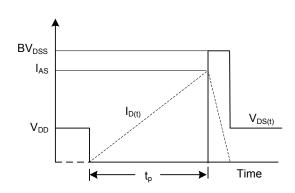




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

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